



BEST AVAILABLE COPY

2882
10175
1/29/04

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of
Donald Dominic ARNONE et al.
Serial No.: 09/914,081
Filed: April 23, 2002

New York, New York
Date: January 20, 2004
Group Art Unit: 2882
Examiner: ---

For: METHOD AND APPARATUS FOR TERAHERTZ IMAGING

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

RECEIVED
JAN 28 2004
TECHNOLOGY CENTER R3700

SUBMISSION

Sir:

Submitted herewith is a copy of art together with a form listing the same for the convenience of the Examiner.

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents P.O. Box 1450, Alexandria, VA 22313-1450, on January 20, 2004

Respectfully submitted,

Max Moskowitz

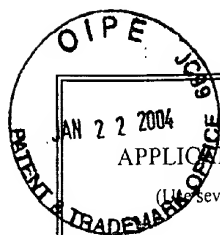
Name of applicant, assignee or
Registered Representative

Signature
January 20, 2004

Date of Signature

Max Moskowitz
Registration No.: 30,576
OSTROLENK, FABER, GERB & SOFFEN, LLP
1180 Avenue of the Americas
New York, New York 10036-8403
Telephone: (212) 382-0700

MM:mjb
Enclosures



APPLICANT'S ART CITATION (Use several sheets if necessary)			Application 09/914,081		OFGS File No. P/25-267	
			Applicant Donald Dominic ARNONE et al.			
			Filing Date April 23, 2002		Group Art Unit 2882	

U.S. PATENT DOCUMENTS							
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate	
	US-5,789,750	08-1998	Nuss	250	338.1	<div style="writing-mode: vertical-rl; transform: rotate(180deg);"> RECEIVED JAN 28 2004 TECHNOLOGY CENTER R3700 </div>	
	US-5,623,145	04-1997	Nuss	250	330		
	US-5,710,430	01-1998	Nuss	250	358.1		
	US-						
	US-						
	US-						
	US-						
FOREIGN PATENT DOCUMENTS							
	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
	WO 97/45747	12-1997	PCT				
	EP 0 841 548 A2	05-1998	EPO				
	EP 0 828 162 A2	03-1998	EPO				
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
	1.	Fattinger, et al., "Point Source Terahertz Optics" Appl. Phys. Lett. 53(16), 17 October 1988, pp. 1480-1482.					
	2.	Fattinger et al., "Tetahertz Beams" Appl. Phys. Lett. 54 (6), 6 February 1989, pp. 490-492					
	3.	Mittleman, et al. "T-Ray Imaging" IEEE Journal of Selected Topics in Quantum Electronics, 2 (3), September 1996, pp. 679-692.					
	4.	Zamdmer et al., "On-Chip Frequency-Domain Submillimeter-Wave Transceiver" Appl. Phys. Lett. 75 (24), 12 December 1999, pp. 3877-3879.					
Examiner		Date Considered					

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.